

# INTERNATIONAL STANDARD

## NORME INTERNATIONALE

Potentiometers for use in electronic equipment –  
Part 1: Generic specification

(standards.iteh.ai)

Potentiomètres utilisés dans les équipements électroniques –  
Partie 1: Spécification générique

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Potentiometers for use in electronic equipment –  
Part 1: Generic specification

Potentiomètres utilisés dans les équipements électroniques –  
Partie 1: Spécification générique

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## CONTENTS

FOREWORD.....	6
1 General.....	8
1.1 Scope.....	8
1.2 Normative references .....	8
2 Technical data.....	10
2.1 Units and symbols .....	10
2.2 Terms and definitions .....	10
2.3 Preferred values .....	28
2.4 Marking.....	28
3 Assessment procedures.....	28
4 Test and measurement procedures .....	28
4.1 General.....	28
4.2 Standard atmospheric conditions .....	29
4.3 Drying .....	30
4.4 Visual examination and check of dimensions .....	30
4.5 Continuity (except for continuously rotating potentiometers) .....	32
4.6 Element resistance .....	32
4.7 Terminal resistance .....	33
4.8 Maximum attenuation.....	33
4.9 Resistance law (conformity) .....	33
4.10 Matching of the resistance law (for ganged potentiometers only).....	34
4.11 Switch contact resistance (when appropriate).....	34
4.12 Voltage proof (insulated styles only).....	38
4.13 Insulation resistance (insulated styles only).....	39
4.14 Variation of resistance with temperature.....	40
4.15 Rotational noise.....	42
4.16 Contact resistance at low-voltage levels.....	44
4.17 Setting ability (adjustability) and setting stability.....	45
4.18 Starting torque.....	49
4.19 Switch torque .....	49
4.20 End stop torque.....	50
4.21 Locking torque.....	50
4.22 Thrust and pull on shaft .....	51
4.23 Shaft run-out .....	52
4.24 Lateral run-out.....	53
4.25 Pilot (or spigot) diameter run-out.....	53
4.26 Shaft end play .....	54
4.27 Backlash .....	55
4.28 Dither .....	57
4.29 Output smoothness.....	58
4.30 Robustness of terminals .....	59
4.31 Sealing.....	60
4.32 Solderability .....	61
4.33 Resistance to soldering heat.....	61
4.34 Change of temperature .....	62

4.35	Vibration.....	63
4.36	Bump .....	64
4.37	Shock.....	64
4.38	Climatic sequence .....	65
4.39	Damp heat, steady state .....	67
4.40	Mechanical endurance (potentiometers).....	68
4.41	AC endurance testing of mains switches on capacitive loads .....	71
4.42	DC endurance testing of switches .....	73
4.43	Electrical endurance .....	74
4.44	Component solvent resistance .....	78
4.45	Solvent resistance of the marking .....	78
4.46	Microlinearity .....	79
4.47	Mounting (for surface mount potentiometers).....	81
4.48	Shear (adhesion) test .....	83
4.49	Substrate bending test (formerly bond strength of the end face plating) .....	83
4.50	Solderability (for surface mount potentiometers).....	83
4.51	Resistance to soldering heat (for surface mount potentiometers) .....	83
Annex A	(normative) Rules for the preparation of detail specifications for capacitors and resistors for electronic equipment .....	84
Annex B	(normative) Interpretation of sampling plans and procedures as described in IEC 60410 for use within the IEC Quality Assessment System for Electronic Components .....	85
Annex C	(normative) Measuring methods for rotational noise .....	86
Annex D	(normative) Apparatus for measuring mechanical accuracy .....	89
Annex E	(normative) Measuring method for microlinearity .....	90
Annex F	(normative) Preferred dimensions of shaft ends, bushes and for the mounting hole, bush-mounted, shaft-operated electronic components .....	92
Annex G	(informative) Example of common potentiometer's law .....	93
Annex H	(normative) Quality assessment procedures .....	95
Figure 1	– Shaft-sealed potentiometer.....	14
Figure 2	– Shaft- and panel-sealed potentiometer.....	14
Figure 3	– Fully sealed potentiometer.....	14
Figure 4	– Linear law .....	16
Figure 5	– Logarithmic law .....	16
Figure 6	– Inverse logarithmic law .....	16
Figure 7	– Output ratio .....	17
Figure 8	– Loading error .....	18
Figure 9	– Total mechanical travel (or angle of rotation) .....	18
Figure 10	– Conformity .....	20
Figure 11	– Absolute conformity .....	20
Figure 12	– Linearity .....	21
Figure 13	– Independent linearity .....	22
Figure 14	– Zero-based linearity.....	23
Figure 15	– Absolute linearity.....	24

Figure 16 – Terminal based linearity.....	25
Figure 17 – Effective tap width .....	25
Figure 18 – Backlash .....	27
Figure 19 – Example of insulation resistance and voltage proof test jig for surface mount potentiometers .....	39
Figure 20 – Test circuit contact resistance.....	45
Figure 21 – Measuring circuit for setting ability (as divider).....	46
Figure 22 – Measuring circuit for setting ability (as current controller) .....	47
Figure 23 – Shaft run-out .....	52
Figure 24 – Lateral run-out.....	53
Figure 25 – Pilot (spigot) diameter run-out.....	54
Figure 26 – Shaft end play .....	55
Figure 27 – Test circuit for measurement of backlash .....	56
Figure 28 – Measurement of backlash .....	57
Figure 29 – Test circuit for measurement of output smoothness .....	58
Figure 30 – The circuit for continuous monitoring of the contact resistance .....	71
Figure 31 – Test circuit a.c. endurance testing .....	72
Figure 32 – Test circuit d.c. endurance testing .....	73
Figure 33 – Example of microlinearity measurement .....	79
Figure 34 – Block diagram of a circuit for evaluation of microlinearity.....	80
Figure 35 – Example of simultaneous evaluation of linearity and microlinearity.....	80
Figure 36 – Suitable substrate for mechanical and electrical tests (may not be suitable for impedance measurements).....	82
Figure 37 – Suitable substrate for electrical tests.....	82
Figure C.1 – Measuring circuit for method A, rotational noise.....	87
Figure C.2 – Measuring circuit for CRV .....	87
Figure C.3 – Measuring circuit for ENR .....	88
Figure E.1 – Block diagram of a digital reference unit (synthetic high-precision master).....	90
Figure G.1 – Definition of rotation (shaft-end view) .....	93
Figure G.2 – Linear law, without centre tap.....	94
Figure G.3 – Linear law, with centre tap .....	94
Figure G.4 – Logarithmic law, without tap .....	94
Figure G.5 – Logarithmic law, with tap.....	94
Figure G.6 – Inverse logarithmic law without tap.....	94
Figure G.7 – Inverse logarithmic law with tap .....	94
Figure H.1 – General scheme for capability approval .....	98
Table 1 – Standard atmospheric conditions .....	30
Table 2 – Measuring voltages .....	32
Table 3 – Calculation of resistance value ( $R$ ) and change in resistance ( $\Delta R$ ).....	41
Table 4 – Calculation of temperature differences ( $\Delta T$ ).....	41
Table 5 – Current values ( $IB_0$ ) .....	43
Table 6 – Moving contact current .....	48
Table 7 – End stop torque.....	50

Table 8 – Locking torque.....	50
Table 9 – Shaft torque .....	51
Table 10 – Thrust and pull .....	51
Table 11 – Thrust and pull .....	52
Table 12 – Backlash .....	57
Table 13 – Dither for non-wire wound types .....	57
Table 14 – Dither for wire wound types (under consideration) .....	58
Table 15 – Tensile force .....	59
Table 16 – Number of cycles .....	66
Table 17 – Number of cycles .....	69
Table 18 – Number of operations .....	73
Table 19 – Panel size .....	75
Table G.1 – Resistance law and code letter .....	93

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# INTERNATIONAL ELECTROTECHNICAL COMMISSION

## POTENTIOMETERS FOR USE IN ELECTRONIC EQUIPMENT –

### Part 1: Generic specification

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International Standard IEC 60393-1 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This bilingual version (2016-05) corresponds to the English version, published in 2008-05.

This third edition cancels and replaces the second edition published in 1989 and constitutes a technical revision, including minor revisions related to tables, figures and references.

This edition contains the following significant technical changes with respect to the previous edition:

- implementation of Annex H which replaces Section 3 of the previous edition.



The text of this standard is based on the following documents:

FDIS	Report on voting
40/1897/FDIS	40/1914/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

The French version of this standard has not been voted upon.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all the parts of the IEC 60393 series, under the general title *Potentiometers for use in electronic equipment*, can be found on the IEC web site.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

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# POTENTIOMETERS FOR USE IN ELECTRONIC EQUIPMENT –

## Part 1: Generic specification

### 1 General

#### 1.1 Scope

This part of IEC 60393 is applicable to all types of resistive potentiometers, including lead-screw actuated types, presets, multi-turn units, etc., to be used in electronic equipment.

It establishes standard terms, inspection procedures and methods of test for use in sectional and detail specifications of electronic components for quality assessment or any other purpose.

It has been mainly written, and the test methods described, to conform to the widely used single-turn rotary potentiometer with an operating shaft.

For other types of potentiometers:

- the angle of rotation may be several turns;
- the reference to an operating shaft shall apply to any other actuating device;
- the angular rotation shall be taken to mean mechanical travel of the actuating device;
- a value for force shall be prescribed instead of a value for torque if the actuating device moves in a linear instead of a rotary manner.

These alternative prescriptions will be found in the sectional or detail specification.

When a component is constructed as a variable resistor, i.e. as a two-terminal device, the detail specification shall prescribe the modifications required in the standard tests.

#### 1.2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60027-1, *Letter symbols to be used in electrical technology – Part 1: General*

IEC 60050 (all parts), *International Electrotechnical Vocabulary (IEV)*

IEC 60062, *Marking codes for resistors and capacitors*

IEC 60063:1963, *Preferred number series for resistors and capacitors*

Amendment 1 (1967)

Amendment 2 (1977)

IEC 60068-1:1988, *Environmental testing – Part 1: General and guidance*

Amendment 1 (1992)

IEC 60068-2-1:1990, *Environmental testing – Part 2: Tests – Tests A: Cold*

Amendment 1 (1993)

Amendment 2 (1994)

IEC 60068-2-2:1974, *Environmental testing – Part 2: Tests – Tests B: Dry heat*  
Amendment 1 (1993)  
Amendment 2 (1994)

IEC 60068-2-6, *Environmental testing – Part 2: Tests – Test Fc : Vibration (sinusoidal)*

IEC 60068-2-13, *Environmental testing – Part 2: Tests – Test M: Low air pressure*

IEC 60068-2-14:1994, *Environmental testing – Part 2: Tests – Test N: Change of temperature*  
Amendment 1 (1986)

IEC 60068-2-17, *Environmental testing – Part 2: Tests – Test Q: Sealing*

IEC 60068-2-20:1979, *Environmental testing – Part 2: Tests – Test T: Soldering*  
Amendment 2 (1987)

IEC 60068-2-21, *Environmental testing – Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices*

IEC 60068-2-27, *Environmental testing – Part 2: Tests – Test Ea and guidance: Shock*

IEC 60068-2-29, *Environmental testing – Part 2: Tests – Test Eb and guidance: Bump*

IEC 60068-2-30, *Environmental testing – Part 2-30: Tests – Test dB : Damp heat, cyclic (12 h + 12 hour cycle)*

IEC 60068-2-45:1980, *Environmental testing – Part 2: Tests – Test XA and guidance: Immersion in cleaning solvents*  
Amendment 1 (1993)

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IEC 60068-2-58, *Environmental testing – Part 2-58: Tests – Test Td: Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)*

IEC 60068-2-78, *Environmental testing – Part 2-78 – Test Cab: Damp heat, steady state*

IEC 60410, *Sampling plans and procedures for inspection by attributes*

IEC 60617, *Graphical symbols for diagrams*

IEC 60915, *Capacitors and resistors for use in electronic equipment – Preferred dimensions of shaft ends, bushes and for the mounting of single-hole, bush-mounted, shaft-operated electronic components*

IEC 61249-2-7, *Materials for printed boards and other interconnecting structures – Part 2-7: Reinforced base materials clad and unclad – Epoxide woven E-glass laminated sheet of defined flammability (vertical burning test), copper-clad*

IECQ 001002-3, *IEC Quality Assessment System for Electronic Components (IECQ) – Rules of procedure – Part 3: Approval procedures*

IECQ 001005, see [www.iecq.org](http://www.iecq.org) for relevant information

ISO 1000, *SI units and recommendations for the use of their multiples and of certain other units*

ISO 9000, *Quality management systems – Fundamentals and vocabulary*

## 2 Technical data

### 2.1 Units and symbols

Units, graphical symbols and letter symbols should, whenever possible, be taken from the following publications:

- IEC 60027-1;
- IEC 60050;
- IEC 60617;
- ISO 1000.

When further items are required they should be derived in accordance with the principles of the publications listed above.

### 2.2 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

#### 2.2.1

##### **type**

group of components having similar design features and the similarity of whose manufacturing techniques enables them to be grouped together for quality conformance inspection. They are generally covered by a single detail specification

NOTE 1 Components described in several detail specifications may, in some cases, be considered as belonging to the same type and may therefore be grouped for quality assessment purpose.

NOTE 2 Mounting accessories are ignored provided they have no significant effect upon the test results.

NOTE 3 Ratings are to be given in the detail specification.

#### 2.2.2

##### **style**

subdivision of a type, generally based on dimensional factors, which may include several variants, generally of a mechanical order

#### 2.2.3

##### **grade**

term indicating additional general characteristics concerning the intended application, for example, long-life applications which may only be used in combination with one or more words (for example, long-life grade) and not by a single letter or number. Figures to be added after the term “grade” should be Arabic numerals

#### 2.2.4

##### **variant**

subdivision within a style having specific dimensions for some part of its construction, for example, terminals, shaft flats or length (see Annex F)

#### 2.2.5

##### **family (of electronic components)**

group of electronic components which predominantly displays a particular physical attribute and/or fulfils a defined function

#### 2.2.6

##### **subfamily (of electronic components)**

group of components within a family manufactured by similar technological methods

**2.2.7****category temperature range**

range of ambient temperatures for which the potentiometer has been designed to operate continuously; this is defined by the temperature limits of its appropriate category

**2.2.8****upper category temperature**

maximum ambient temperature for which a potentiometer has been designed to operate continuously at that portion of the rated dissipation which is indicated in the category dissipation (see 2.2.13)

**2.2.9****lower category temperature**

minimum ambient temperature for which a potentiometer has been designed to operate continuously

**2.2.10****critical resistance**

resistance value at which the rated voltage is equal to the limiting element voltage. Below the critical resistance the maximum voltage which may be applied across the terminals of a potentiometer is the rated voltage. Above that value the maximum voltage is the limiting element voltage (see 2.2.12, 2.2.14 and 2.2.15)

**2.2.11****nominal total resistance**

resistance value for which the potentiometer has been designed and which is generally marked upon the potentiometer

**2.2.12****rated dissipation**

maximum allowable dissipation between terminals **a** and **c** (see 2.2.29) of a potentiometer at an ambient temperature of 70 °C under the conditions of the electrical endurance test at 70 °C which will result in a change in resistance not greater than that specified for that test

NOTE 1 In practice, the dissipation is modified by the following conditions.

NOTE 2 For high values of resistance, the limiting element voltage (see 2.2.15) may prevent the rated dissipation being attained.

NOTE 3 For the dissipation at temperatures other than 70 °C, reference should be made to the rating graphs in the relevant detail specification.

NOTE 4 For situations where only terminals **a** and **b** or **b** and **c** are being used and the control shaft is set at an angle less than 100 % of the effective electrical travel, the limiting moving contact current (see 2.2.17) should also be taken into account.

**2.2.13****category dissipation**

maximum allowable dissipation under continuous load at an ambient temperature equal to the upper category temperature, normally expressed as a percentage of the rated dissipation

NOTE The category dissipation may be zero.

**2.2.14****rated voltage**

d.c. or a.c. r.m.s. voltage calculated from the square root of the product of the nominal total resistance and the rated dissipation

NOTE At high values of resistance, the rated voltage may not be applicable because of the size and construction of the potentiometer (see 2.2.10, 2.2.12 and 2.2.15).

### 2.2.15

#### **limiting element voltage**

maximum d.c. or a.c. r.m.s. voltage which may be applied across the element of a potentiometer

NOTE 1 When the term “a.c. r.m.s. voltage” is used in this specification, the peak voltage should not exceed 1,42 times the r.m.s. value.

NOTE 2 This voltage should only be applied to potentiometers when the resistance value is equal to, or higher than, the critical value.

### 2.2.16

#### **insulation voltage**

maximum peak voltage under continuous operating conditions which may be applied between the potentiometer terminals and other external conducting parts connected together

NOTE The value of the insulation voltage should be not less than 1,42 times the limiting element voltage at normal air pressure. Under conditions of low air pressure, the value of the insulation voltage will be less and should be given in the detail specifications.

### 2.2.17

#### **limiting moving contact current**

maximum current that may be passed between the resistance element and the moving contact

### 2.2.18

#### **variation of resistance and voltage output ratio with temperature**

can be expressed either as a temperature characteristic or as a temperature coefficient as defined below

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#### 2.2.18.1

##### **temperature characteristic of resistance**

maximum reversible variation of resistance produced over a given temperature range within the category temperature range, expressed normally as a percentage of the resistance related to a reference temperature of 20 °C

#### 2.2.18.2

##### **temperature coefficient of resistance ( $\alpha_r$ )**

relative variation of resistance between two given temperatures (mean coefficient), divided by the difference in temperature producing it, preferably expressed in parts per million per °C ( $10^{-6}/K$ )

NOTE It should be noted that use of the term does not imply that any degree of linearity for this function, nor should any be assumed.

#### 2.2.18.3

##### **temperature coefficient of output ratio ( $\alpha_o$ )**

relative variation of voltage output ratio between two given temperatures (mean coefficient) at fixed values of setting and load of the moving contact, divided by the difference in temperature producing it, preferably expressed in parts per million per °C

NOTE 1 The value of  $\alpha_o$  may be different for different settings of the output ratio.

NOTE 2 It should be noted that the use of the term does not imply that the function exhibits any degree of linearity, nor should any be assumed.

### 2.2.19

#### **visible damage**

damage which reduces the usability of the potentiometer for its intended purpose

**2.2.20****potentiometer**

component for use as a voltage divider with three terminals of which two are connected to the ends of a resistive element and the third is connected to a moving contact which can be moved mechanically along the resistive element

**2.2.21****pre-set or trimmer (or trimming) potentiometer**

potentiometer designed for relatively infrequent adjustment

**2.2.22****lead-screw actuated potentiometer**

potentiometer having a lead-screw as multi-turn actuating device

**2.2.23****ganged potentiometers**

potentiometers consisting of two or more sections operated by a common operating shaft. The number of sections shall be included in the description, for example, 2-ganged potentiometer or 4-ganged potentiometer

**2.2.24****dual concentric potentiometers**

potentiometers consisting of two sections operated independently by concentric operating shafts

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**2.2.25****shaft-sealed potentiometer** (standards.iteh.ai)

potentiometer in which a shaft seal is provided to prevent particles and fluid from passing from the exterior of the potentiometer to the interior by way of the shaft bearing (see Figure 1)

<https://standards.iteh.ai/catalog/standards/sist/aefe1538-d275-475e-ba61-aac6de65713d/iec-60393-1-2008>

**2.2.26****shaft-sealed and panel-sealed potentiometer**

potentiometer in which a shaft seal and a panel seal are provided to prevent particles and fluid from entering any equipment in which this potentiometer is mounted (see Figure 2)

**2.2.27****fully sealed potentiometer**

potentiometer in which a shaft seal is provided and the housing of the potentiometer is designed to prevent particles and fluid from passing from the exterior of the potentiometer to the interior (see Figure 3)

In some cases a panel seal may additionally be provided.

Such a potentiometer is called a “fully sealed potentiometer” (see Figure 3).